

Notice of References Cited

Application/Control No.

10/045,354

Applicant(s)/Patent Under
R^e examination
HUI ET AL.

Examiner

Khiem D Nguyen

Art Unit

2823

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-			
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	M	US-			

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	U	U.S. Pub. 2002/0117706 Shimizu (Aug. 29, 2002).
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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